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Quantum photonics hybrid integration platform

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Fundamental to integrated photonic quantum computing is an on-chip method for routing and modulating quantum light emission. We demonstrate a hybrid integration platform consisting of arbitrarily designed waveguide circuits and single-photon sources. InAs quantum dots (QD) embedded in GaAs are bonded to a SiON waveguide chip such that the QD emission is coupled to the waveguide mode. The waveguides are SiON core embedded in a SiO2 cladding. A tuneable Mach Zehnder interferometer (MZI) modulates the emission between two output ports and can act as a path-encoded qubit preparation device. The single-photon nature of the emission was verified using the on-chip MZI as a beamsplitter in a Hanbury Brown and Twiss measurement. © 2015 AIP Publishing LLC [http://dx.doi.org/10.1063/1.4935029]

Linear optical quantum computing has been proven to be computationally efficient with single-photon-sources, beamsplitters, and phase shifters.1 Although few photon gates have been demonstrated using bulk optics,2 scaling to more complex circuits requires an integrated photonic technology.3

Integrated photonics offers the potential for true scalability due to component miniaturisation. Stability is intrinsic to the platform and offers a reduction in complexity and size of the device.4 Many of the elements needed for linear optical quantum computing can be manufactured on-chip. High-fidelity beam splitters and Mach Zehnder interferometers (MZIs) can be made with various semiconductor platforms5–7 as well as on-chip detectors.8,9 However, thus far, integration of single-photon sources into low-loss waveguides remains an open issue.

Semiconductor III–V quantum dots (QDs) have been shown to produce bright, single-photon emission.10 Although indistinguishable and entangled photons,11,12 can be site-controlled,13 and compatible with semiconductor foundry techniques. Various approaches for embedding QDs into integrated circuits are being explored. Photonic crystal waveguides yield high coupling efficiency of the quantum emission into the in-plane propagating waveguide mode.14,15 They can produce in-plane indistinguishable photons.16 However, as of yet in photonic crystal waveguides, no directional couplers or active modulators with embedded QDs have been demonstrated. QDs embedded in ridge waveguides in GaAs have been reported combined with the on-chip superconducting single-photon detectors.17 Air-clad GaAs ridge waveguides have also demonstrated QD integrated directional couplers.18,19 Other approaches use heralded single-photon states from spontaneous parametric down conversion integrated with waveguide chips.20 However, this approach lacks deterministic emission.

In this letter, we present a platform for hybrid integration of III–V QDs with silicon oxynitride waveguides. A GaAs chip containing InAs quantum dots is bonded orthogonally to the SiON chip such that the photons emitted from the surface of the GaAs chip are routed into a guided mode. The quantum dots are embedded in a distributed Bragg reflector cavity with alternating layers of AlAs and GaAs. The SiON chip includes waveguide to deliver laser excitation light to the quantum dots and a return line consisting of a MZI. The MZI can act as a qubit preparation device for the single-photons emitted from the QD. If a single-photon impinges on the MZI, it will be placed into a path-encoded superposition of each output mode. The probability amplitude of being in each mode is chosen by the tuning of the MZI. This SiON technology is compatible with the creation of arbitrary designs of beamsplitters, MZIs, and phase shifters.

Orthogonal bonding allows the surface emission from the QD to be optimised by growing a distributed Bragg reflector cavity and/or creating a micropillar structure. Previous reports show efficiencies of out-of-plane QD collection as high as 0.75 into free space high numerical aperture objectives.21,22 In the device presented here, the SiON waveguide numerical aperture is 0.3. The hybrid platform also has the potential for diode structures to be created for electrically driven or tuneable QD devices integrated with the waveguides.

Figure 1(a) shows a photograph of a hybrid device. A strip of III–V containing QDs is bonded to one end of the SiON waveguide chip. The QD source was grown by molecular beam epitaxy. A QD density was chosen such that a dot, which emits in the centre cavity mode, is aligned with a waveguide. The central cavity wavelength is 910 nm. Plasma enhanced chemical vapour deposition was used to create a layer of SiO2 undercladding and SiON core on a silicon substrate. Electron-beam lithography and reactive ion etching.

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were used to define the SiON core profile before finally a SiO\textsubscript{2} overclad layer was deposited. The orthogonal bonding method allows the surface emission from the QD to be collected by the waveguide. The photons are routed into the waveguides, two sequential directional couplers form a MZI with a nickel-chromium alloy heater, applying a local phase shift to one MZI arm. A polarisation-maintaining V-groove array is aligned and attached to the waveguides for collection. The device is kept at 4 K for the duration of the experiments.

Figure 1(b) shows the optical schematic of the experiments. A single channel delivers laser light. The QD light is returned through the MZI and collected into fibre by the V-groove array. The V-groove fibres are sent directly to a spectrometer. For time resolved experiments, transmission gratings are used to spectrally filter the emission before sending the light to avalanche photodiodes.

The characteristics of the device were simulated by using the finite difference time domain package MEEP\textsuperscript{23,24} A $\hat{z}$ oriented dipole emitter was placed in the centre of the cavity spacer aligned to the centre of the waveguide. A perfectly matched layer was placed at the edges of the simulation domain to absorb all light and prevent unwanted reflections. The $\hat{z}$ component of the electric field is shown in Fig. 1(c). There is a clear emission pattern along the waveguide core.

The efficiency of this device was determined theoretically. A bounding box, which records the Fourier transformed fields, was placed at the edge of the domain and just inside the perfectly matched layer. From this bounding box, the total power spectrum is recorded when the system is excited with a short Gaussian pulse. Another flux plane is placed across the waveguide. The waveguide core size was 1.6 \textmu m and the far field propagating mode has a spatial $1/e$ width of 1.88 \textmu m which was chosen as the size of the waveguide flux plane. It is placed sufficiently far from the surface of the III-V structure so that only the waveguide propagating mode is measured. Taking the ratio of the light propagating in the waveguide to the total in the bounding box gives the efficiency of the QD emission into the waveguide to be 2.8\%. This is considerably higher for a QD in bulk of 0.5\% and could be further enhanced with higher-Q cavities.

The integrated device is fixed, once the bonding is complete. This creates stability and no drifting in emission intensity is seen over the course of 12 h. The QD intensity as a function of time is plotted in Fig. 2(c). The MZI was tuned to 50:50 and the spectrum from both outputs of the device can be seen in Fig. 2(a). The QD analysed was located at the centre of the cavity mode at 1.362 eV. A power dependent spectrum was recorded as seen in Fig. 2(b). The emission, before saturation, is approximately linear ($\propto P^{0.95}$) implying an exciton and not a higher order complex.\textsuperscript{25} The peak does not exhibit the polarisation splitting which is characteristic of a neutral exciton\textsuperscript{26,27} and is therefore likely to derive from a charged exciton.

To verify the single-photon nature of the QD emission, a Hanbury Brown and Twiss experiment was recorded using the on-chip MZI as a beamsplitter. Using MZI’s on chip is a powerful technique due to the reconfigurability of the circuit.\textsuperscript{3} They can be used as directional couplers with chosen reflectivity. The emission from both MZI output arms (ports 1 and 2 in Fig. 1(b)) was sent through two different...
transmission gratings for spectral filtering and then sent to avalanche photodiodes. The clicks on each detector were correlated. The value of $g^{(2)}(\tau)$ was determined by normalising the correlation histogram to have $g^{(2)}(\tau)$ at the maximum delay to unity, when the photons are uncorrelated. The $g^{(2)}(\tau)$ function is given by $g^{(2)}(\tau) = \langle I(t)I(t+\tau) \rangle / \langle I(t) \rangle^2$. An absence of correlation coincidences at time $\tau = 0$ implies that the device is a good single-photon source. The second order correlation curves were taken under continuous wave (CW) ($\lambda = 810$ nm) and pulsed ($\lambda = 850$ nm) excitation. The curves are shown in Fig. 3. In the case of the pulsed curve (shown in Fig. 3(a)), the signal to noise ratio due to dark counts of the detectors was calculated and subtracted. A time window was also applied to the data, since the lifetime of the QD was 670 ± 3 ps. The vast majority (96%) of QD emission resides in a 4 ns window. So only coincidences inside this window were used for calculating the $g^{(2)}(0)$ value of 0.19. The laser was delivering 3 ps long pulses, but the carriers created in the GaAs bandgap may live for 100 s of ps before decay, so the dot can refill over a 100 ps timescale. After emission, the QD will remain empty until the next pulse. The QD emission is then a regulated stream of photons synchronised to the clock of the laser.

In the CW case, as seen in Fig. 3(b), the black circles correspond to the data. The red line is a fit to the data. The dashed blue line is a fit, which takes into account the Gaussian response function of the detectors and timing system, and thus is a representation of the true $g^{(2)}(0)$ of the source. The $g^{(2)}(0)$ value was taken from this fit to be 0.09. In CW excitation, the QD can emit a photon and immediately be repopulated due to the constant excitation of carriers around the QD. The stream of photons is still made up of antibunched photons; however, there is no time synchronisation.

Although it is well known that a MZI can be thought of a generalised tuneable beamsplitter, the statistics of the photon source were pre-characterised in those cases. If the source is known to be emitting single photons, the MZI gives the same correlation as a single beamsplitter. Fig. 3(b) shows $g^{(2)}(0)$ to be 0.09, after the system response is accounted for, indicating the sub-Poissonian statistics of the source.

The active modulation of the MZI was tested on the single-photon source. A voltage was applied to the heater on one arm of the MZI. This induces local heating of the arm and a change in the refractive index of the waveguide core. This change creates a relative phase between the light in each arm of the MZI. At the second directional coupler, the light will constructively or destructively interfere, depending on the relative phase, and couple between the two output ports. Thus, emission coupling to each output arm of the MZI then varies as a function of the applied voltage. The coupling ratio of the device is defined as the power in one arm divided by the sum: $r = P_1/(P_1 + P_2)$, where $P_i$ is the power in output port $i$ in Fig. 1(b). The coupling ratio is shown in Fig. 4 along with the calculated phase. The black line is a fit to the coupling ratio, extrapolated after 22 V to show the expected behaviour. It is seen that the phase (red line) is zero when all the light is coupled to port 1. A $\pi$ phase shift is seen when the voltage is changed from 0 V to 22 V.

In conclusion, we have demonstrated a method for integrating a III-V quantum light source with a SiON waveguide platform. The single-photon nature of the source was verified using on-chip components, and the active modulation of the emission was demonstrated. This device shows potential for the integration of site controlled QDs granting precise alignment of multiple QDs with multiple waveguides allowing for scalable quantum manipulation.

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FIG. 4. The measured coupling ratio of the MZI as a function of applied voltage. The solid black line is a fit to the data. The red line is the calculated phase.

FIG. 3. (a) Second order correlation function under pulsed excitation. (b) Second order correlation function under continuous wave excitation. The black circles are the raw data, the red line is a fit to the data, and the dashed blue line is the fit taking the Gaussian system response into account.